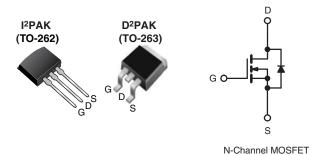




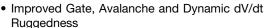
Power MOSFET

PRODUCT SUMMARY			
V _{DS} (V)	500		
R _{DS(on)} (Max.) (Ω)	V _{GS} = 10 V	1.40	
Q _g (Max.) (nC)	24		
Q _{gs} (nC)	6.3		
Q _{gd} (nC)	11		
Configuration	Single		



FEATURES

- Halogen-free According to IEC 61249-2-21 **Definition**
- Low Gate Charge Q_g Results in Simple Drive Requirement





- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High speed power switching

TYPICAL SMPS TOPOLOGIES

- Two Transistor Forward
- Half Bridge and Full Bridge

ORDERING INFORMATION				
Package	D ² PAK (TO-263)	D ² PAK (TO-263)	I ² PAK (TO-262)	
Lead (Pb)-free and Halogen-free	SiHF830AS-GE3	SiHF830ASTRL-GE3 ^a	SiHF830AL-GE3 ^a	
Lead (Pb)-free	IRF830ASPbF	IRF830ASTRLPbFa	IRF830ALPbF	
	SiHF830AS-E3	SiHF830ASTL-E3 ^a	SiHF830AL-E3	

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	7 v	
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm GS}$ at 10 V $T_{\rm C} = 25 ^{\circ}$ C $T_{\rm C} = 100 ^{\circ}$ C	- I _D	5.0		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C		3.2	Α	
Pulsed Drain Current ^{a, e}			I _{DM}	20		
Linear Derating Factor				0.59	W/°C	
Single Pulse Avalanche Energy ^{b, e}		E _{AS}	230	mJ		
Avalanche Current ^a			I _{AR}	5.0	Α	
Repetiitive Avalanche Energy ^a			E _{AR}	7.4	mJ	
Maximum Power Dissipation	T _A = 25 °C		P_{D}	3.1	W	
Maximum Fower Dissipation	T _C =	25 °C	гD	74	- vv	
Peak Diode Recovery dV/dt ^{c, e}		dV/dt	5.3	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	1	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 18 mH, R_g = 25 Ω , I_{AS} = 5.0 A (see fig. 12).
- c. $I_{SD} \le 5.0$ A, $dI/dt \le 370$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.
- e. Uses SiHF830A data and test conditions.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRF830AS, IRF830AL, SiHF830AS, SiHF830AL

Vishay Siliconix



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient (PCB Mounted, Steady-State) ^a	R _{thJA}	-	40	°C/W
Maximum Junction-to-Case (Drain)	R_{thJC}	-	1.7	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		-				·	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 250 μA	500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA ^d		-	0.60	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		_	4.5	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 30 V	-	-	± 100	nA
Zara Cata Valta a Duais Comment		V _{DS} :	= 500 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	_	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.0 A ^b	-	-	1.4	Ω
Forward Transconductance	9fs	V _{DS} :	= 50 V, I _D = 3.0 A ^d	2.8	_	-	S
Dynamic						•	
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	620	-	
Output Capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5 ^d		93	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.			4.3	-	
Output Conscitones	0		V _{DS} = 1.0 V, f = 1.0 MHz	-	886	-	
Output Capacitance	C_{oss}	$V_{GS} = 0 V$	V _{DS} = 400 V, f = 1.0 MHz	-	27	-	
Effective Output Capacitance	C _{oss} eff.		V _{DS} = 0 V to 400 V ^{c, d}	-	39	-	
Total Gate Charge	Q_g			-	-	24	
Gate-Source Charge	Q_{gs}	$V_{GS} = 10 \text{ V}$ $I_D = 5.0 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^{b, d}		-	-	6.3	nC
Gate-Drain Charge	Q _{gd}		See fig. 6 and 16		-	11	
Turn-On Delay Time	t _{d(on)}	V _{DD} = 250 V, I _D = 5.0 A,		-	10	-	
Rise Time	t _r			-	21	-	
Turn-Off Delay Time	t _{d(off)}	$R_g = 14 \Omega$,	$R_D = 49 \Omega$, see fig. $10^{b, d}$	-	21	-	ns
Fall Time	t _f		1		15	-	1
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the integral reverse p - n junction diode		-	5.0	Α
Pulsed Diode Forward Current ^a	I _{SM}				-	20	
Body Diode Voltage	V_{SD}	T _J = 25 °C	V_{c} , $I_{S} = 5.0 \text{ A}$, $V_{GS} = 0 \text{ V}^{b}$	-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _ 25 °C 1	- 5 0 A dl/dt - 100 A/: ab d	-	430	650	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 5.0 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^{\text{b}, d}$		-	2.0	3.0	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	on is dor	ninated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80 % V_{DS} .
- d. Uses SiHF830A data and test conditions.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

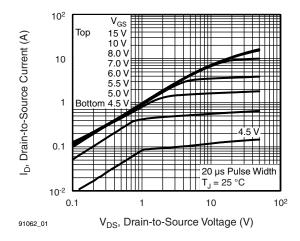


Fig. 1 - Typical Output Characteristics

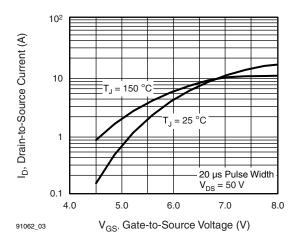


Fig. 3 - Typical Transfer Characteristics

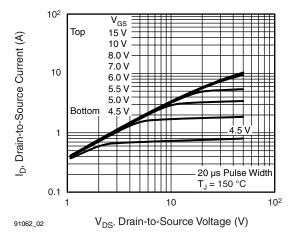


Fig. 2 - Typical Output Characteristics

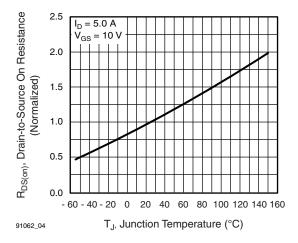


Fig. 4 - Normalized On-Resistance vs. Temperature



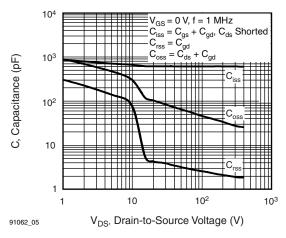


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

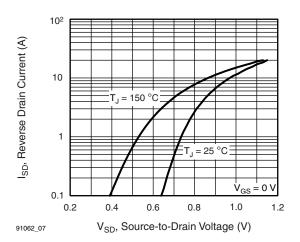


Fig. 7 - Typical Source-Drain Diode Forward Voltage

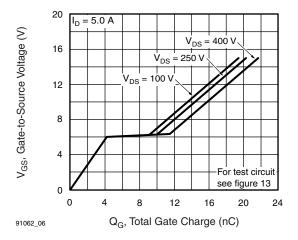


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

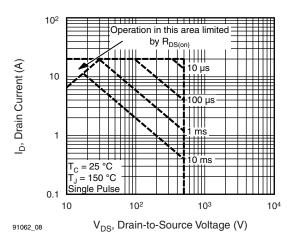


Fig. 8 - Maximum Safe Operating Area



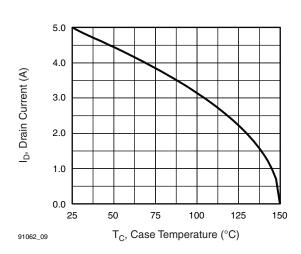


Fig. 9 - Maximum Drain Current vs. Case Temperature

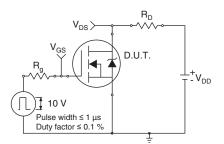


Fig. 10a - Switching Time Test Circuit

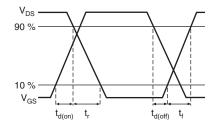


Fig. 10b - Switching Time Waveforms

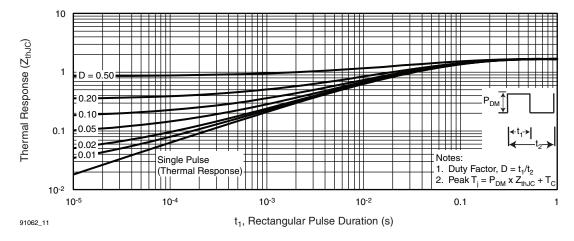


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

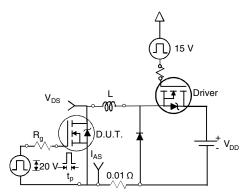


Fig. 12a - Unclamped Inductive Test Circuit

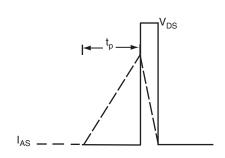


Fig. 12b - Unclamped Inductive Waveforms



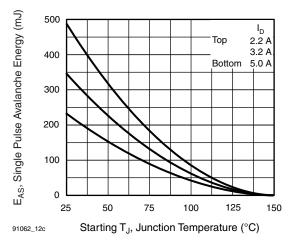


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

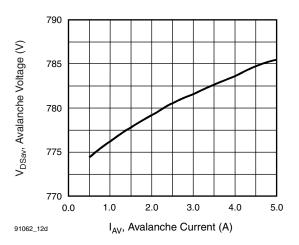


Fig. 12d - Basic Gate Charge Waveform

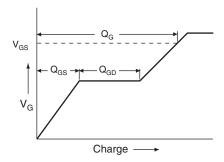


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

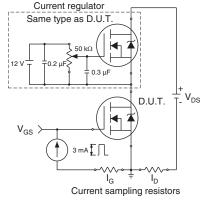
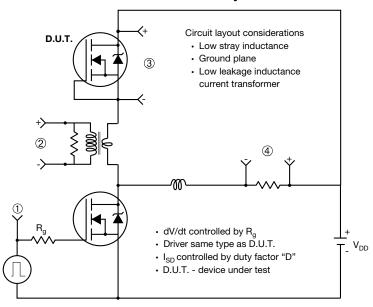


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



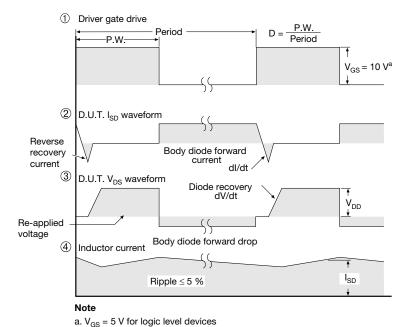
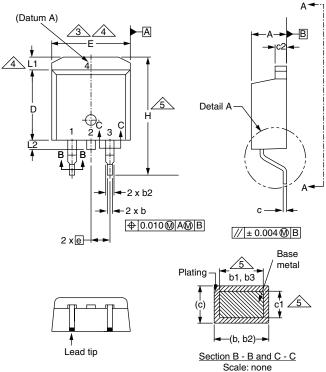


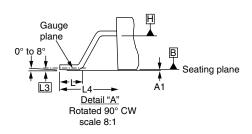
Fig. 14 - For N-Channel

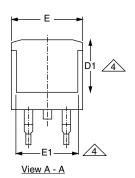
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TO-263AB (HIGH VOLTAGE)







lating –	b1, b3	/ metal
(c)		of 25
Ļ	← (b, b2) →	
Sect	ion B - B ar	
	Scale: nor	ne

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380
ECN: S-82110-Rev. A, 15-Sep-08				

MIN. 0.270	MAX.
	-
700	
0.360	0.420
0.245	ı
0.100 BSC	
0.575	0.625
0.070	0.110
-	0.066
-	0.070
0.010	BSC
0.188	0.208
	0.100 0.575 0.070 - - 0.010

DWG: 5970 Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

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Revision: 02-Oct-12 Document Number: 91000